

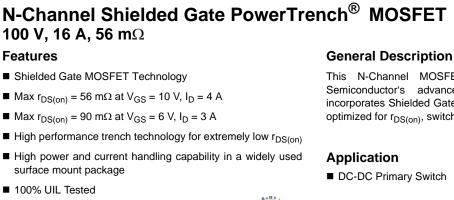
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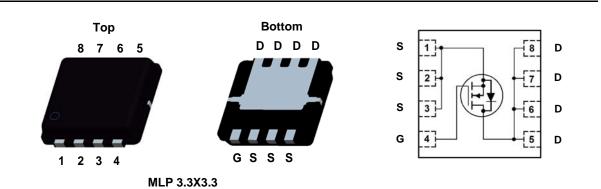


Termination is Lead-free and RoHS Compliant

FAIRCHILD

**FDMC8622** 

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process that incorporates Shielded Gate technology. This process has been optimized for r<sub>DS(on)</sub>, switching performance and ruggedness.



# **MOSFET Maximum Ratings** T<sub>A</sub> = 25 °C unless otherwise noted

Symbol	Param		Ratings	Units	
V <sub>DS</sub>	Drain to Source Voltage			100	V
V <sub>GS</sub>	Gate to Source Voltage			±20	V
	Drain Current -Continuous	T <sub>C</sub> = 25 °C		16	
I <sub>D</sub>	-Continuous	TA = 25 °C	(Note 1a)	4	Α
	-Pulsed		(Note 4)	30	
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	37	mJ
P <sub>D</sub>	Power Dissipation	T <sub>C</sub> = 25 °C		31	w
	Power Dissipation	(Note 1a)	2.3	vv	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range			-55 to +150	°C

# **Thermal Characteristics**

$R_{\thetaJC}$	Thermal Resistance, Junction to Case	(Note 1)	4.0	°C/W
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	53	C/vv

# **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC8622	FDMC8622	MLP 3.3X3.3	13 "	12 mm	3000 units

June 2014

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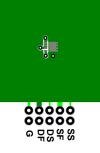
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0 \ V$	100			V
ΔΒV <sub>DSS</sub> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		69		mV/°C
DSS	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 80 V, V <sub>GS</sub> = 0 V			1	μΑ
GSS	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA
On Chara	octeristics					
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \ \mu A$	2	2.9	4	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		-9		mV/°C
		$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 4 \text{ A}$		43.7	56	
DS(on)	Static Drain to Source On Resistance	$V_{GS} = 6 V, I_D = 3 A$		59.9	90	mΩ
		$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 4 \text{ A}, \text{ T}_{J} = 125 \text{ °C}$		76.4	98	
Ĵfs	Forward Transconductance	$V_{DD} = 10 \text{ V}, I_D = 4 \text{ A}$		8.9		S
Dvnamic	Characteristics					
C <sub>iss</sub>	Characteristics Input Capacitance Output Capacitance	V <sub>DS</sub> = 50 V, V <sub>GS</sub> = 0 V,		302 72 5	402	pF
C <sub>iss</sub> C <sub>oss</sub>	Input Capacitance Output Capacitance	$V_{DS} = 50 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$ f = 1 MHz		72.5	96	pF
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input Capacitance				-	
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> R <sub>g</sub>	Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance			72.5 4.2	96	pF pF
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> R <sub>g</sub> Switching	Input Capacitance Output Capacitance Reverse Transfer Capacitance			72.5 4.2	96	pF pF
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> Rg Switching	Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Characteristics			72.5 4.2 1.0	96 6	pF pF Ω
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> R <sub>g</sub> Switching	Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time	f = 1 MHz		72.5 4.2 1.0 5.9	96 6 12	pF pF Ω ns
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> <b>Switching</b> d(on) tr td(off)	Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time	f = 1  MHz V <sub>DD</sub> = 50 V, I <sub>D</sub> = 4 A, V <sub>GS</sub> = 10 V, R <sub>GEN</sub> = 6 Ω		72.5 4.2 1.0 5.9 1.6	96 6 12 10	pF pF Ω ns ns
Criss Criss Criss Criss Criss Criss Criss Colon Criss Colon Criss Colon Criss	Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Turn-On Delay Time Rise Time Turn-Off Delay Time	f = 1  MHz V <sub>DD</sub> = 50 V, I <sub>D</sub> = 4 A, V <sub>GS</sub> = 10 V, R <sub>GEN</sub> = 6 Ω		72.5 4.2 1.0 5.9 1.6 10.2	96 6 12 10 18	pF pF Ω ns ns
Ciss Coss Crss Rg Switching td(on) tr td(off) td(off) td Qg(TOT)	Input Capacitance         Output Capacitance         Reverse Transfer Capacitance         Gate Resistance <b>g Characteristics</b> Turn-On Delay Time         Rise Time         Turn-Off Delay Time         Fall Time	f = 1  MHz V <sub>DD</sub> = 50 V, I <sub>D</sub> = 4 A, V <sub>GS</sub> = 10 V, R <sub>GEN</sub> = 6 Ω		72.5 4.2 1.0 5.9 1.6 10.2 2.2	96 6 12 10 18 10	pF pF Ω ns ns ns
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> R <sub>g</sub>	Input Capacitance         Output Capacitance         Reverse Transfer Capacitance         Gate Resistance <b>g Characteristics</b> Turn-On Delay Time         Rise Time         Turn-Off Delay Time         Fall Time         Total Gate Charge	f = 1 MHz		72.5 4.2 1.0 5.9 1.6 10.2 2.2 5.2	96 6 12 10 18 10 7.3	pF pF Ω ns ns ns nc

**Electrical Characteristics**  $T_J = 25 \text{ °C}$  unless otherwise noted

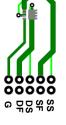
V.	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_{S} = 4 A$	(Note 2)	0.8	1.3	V
V <sub>SD</sub> Source to Drain Diode Forward Voltage		$V_{GS} = 0 V, I_{S} = 1.7 A$	(Note 2)	0.8	1.2	v
t <sub>rr</sub>	Reverse Recovery Time		36	57	ns	
Q <sub>rr</sub>	Reverse Recovery Charge	I <sub>F</sub> = 4 A, di/dt = 100 A/μs		28	45	nC
NOTEO						

NOTES:

1. R<sub>0JA</sub> is determined with the device mounted on a 1in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>0JC</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.



a. 53°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper

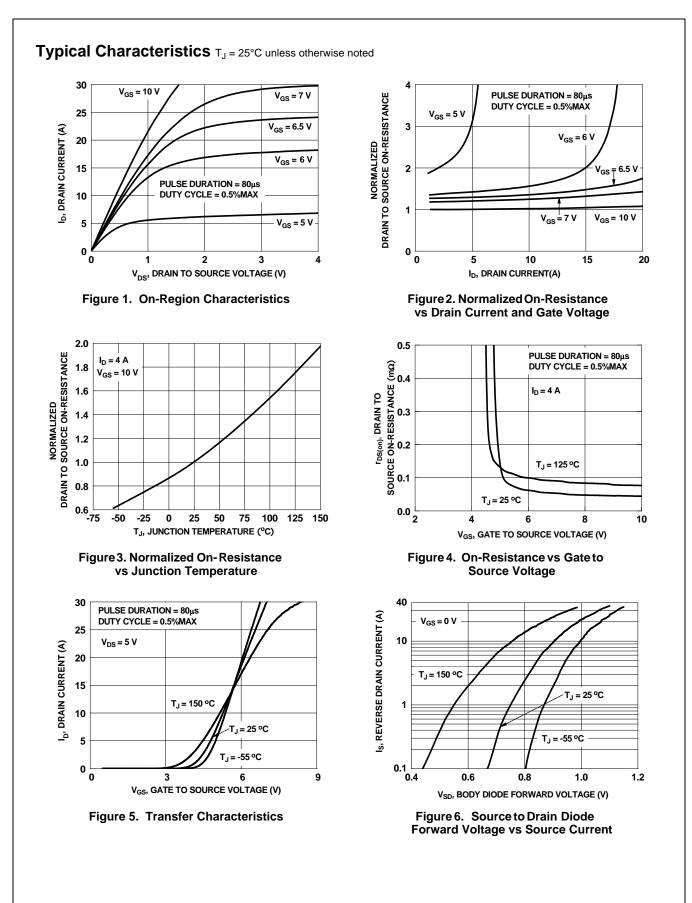


b. 125 °C/W when mounted on a minimum pad of 2 oz copper

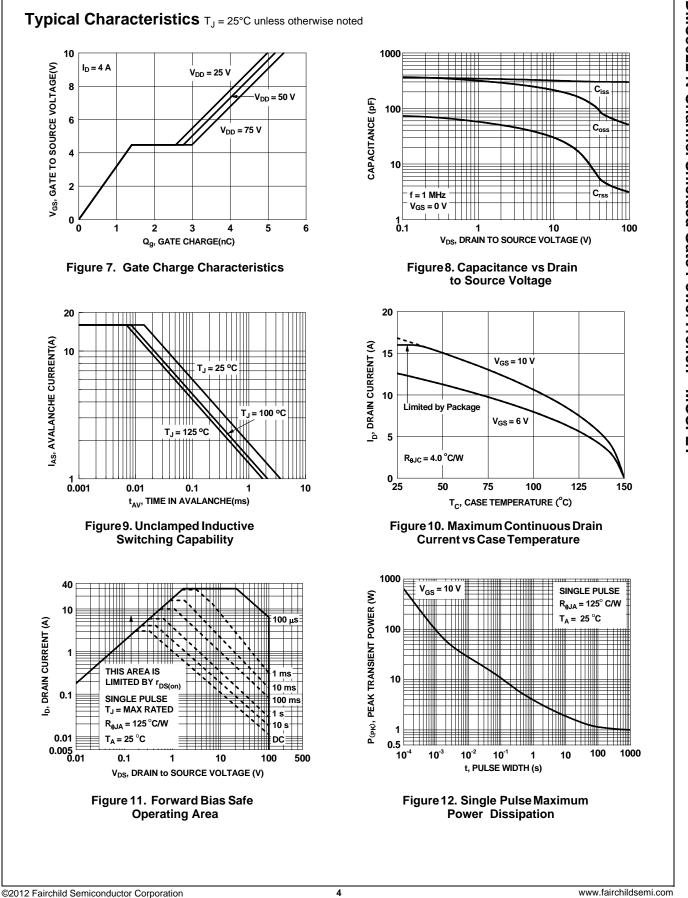
2. Pulse Test: Pulse Width < 300  $\mu s,$  Duty cycle < 2.0%.

3. Starting T \_J = 25 °C; N-ch: L = 3.0 mH, I \_{AS} = 5.0 A, V \_{DD} = 100 V, V \_{GS} = 10 V.

4. Pulse Id refers to Figure.11 Forward Bias Safe Operation Area.



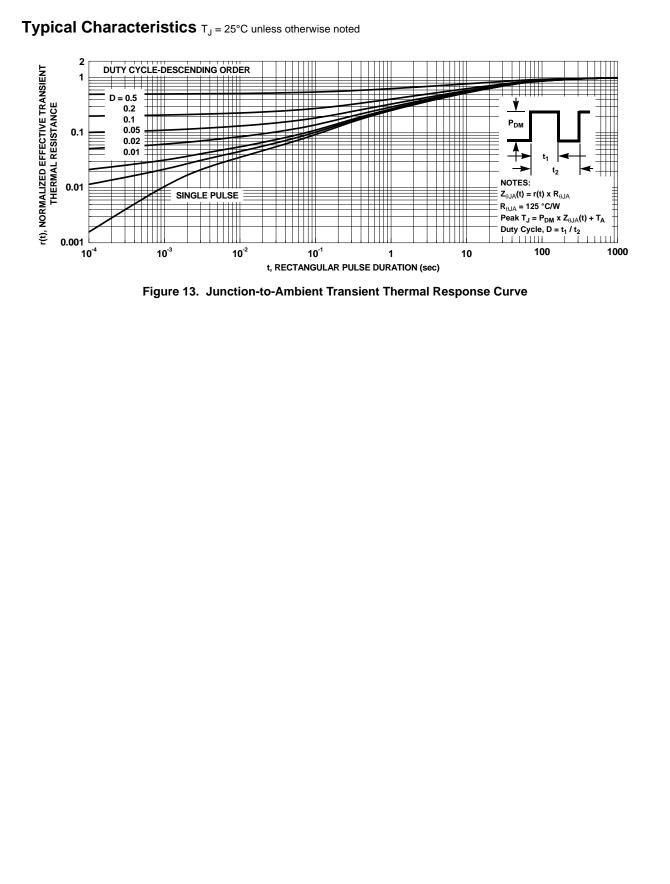
©2012 Fairchild Semiconductor Corporation FDMC8622 Rev.C6

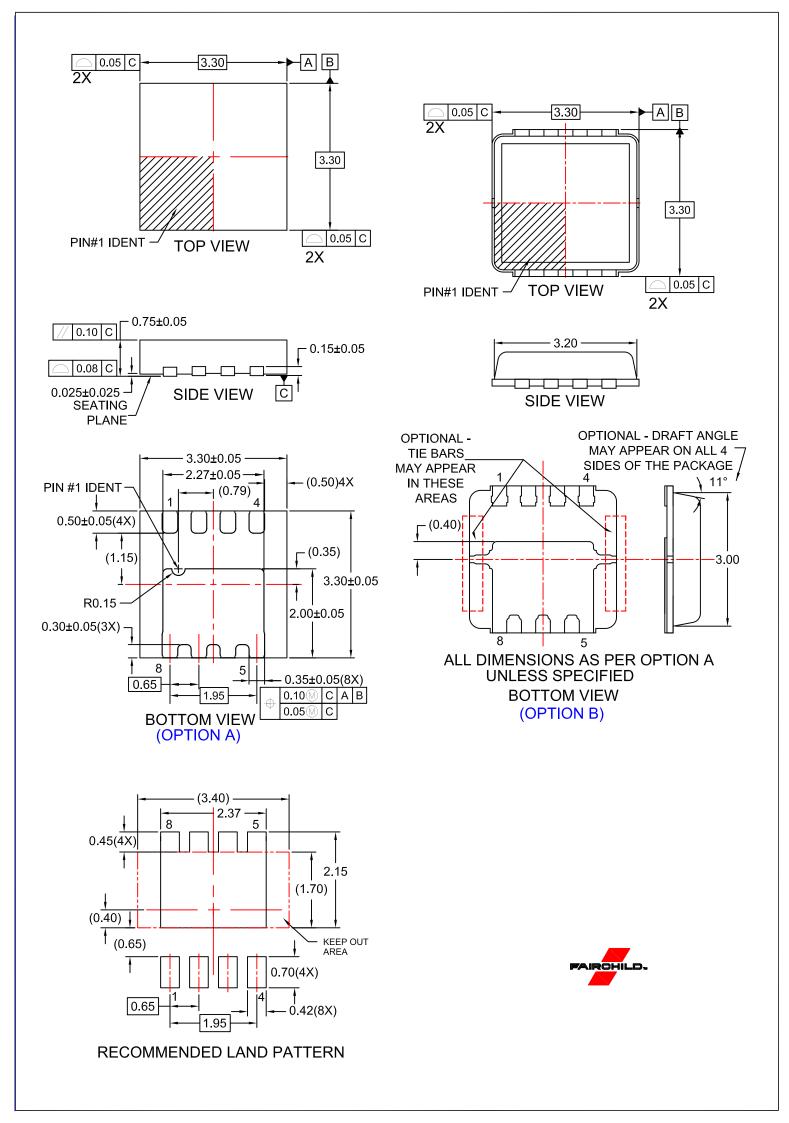


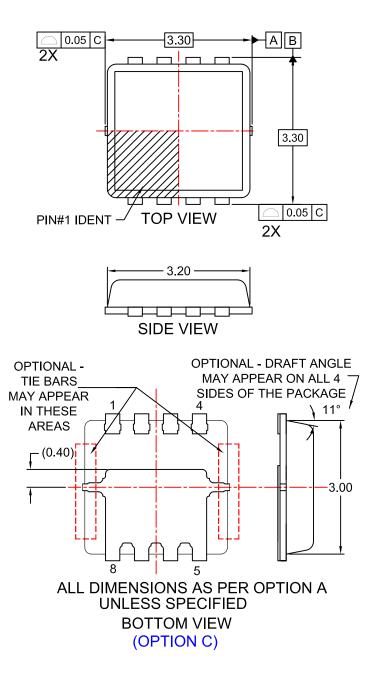
FDMC8622 Rev.C6

FDMC8622 N-Channel Shielded Gate PowerTrench<sup>®</sup> MOSFET

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## NOTES:

- A. PACKAGE DOES NOT FULLY CONFORM TO JEDEC REGISTRATION MO-240.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN
- E. DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. BURRS OR MOLD FLASH SHALL NOT EXCEED 0.10MM.
   F. DRAWING FILENAME: MKT-MLP08Wrev3.
- G. OPTION A SAWN MLP, OPTIONS B & C PUNCH MLP.





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No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.			
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